

Experimental evaluation of response functions of a CdTe detector in the diagnostic region with the aim of carrying out a basic experiment concerning a next generation photon counting system

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Aims and objectives

X-ray examinations in the medical field are now widely available, and they are carried out routinely in clinics and hospitals throughout the world. If an innovative technique is developed to improve examinations using standard diagnostic X-ray equipment, it will have a meaningful contribution to improve our quality of life.

The traditional X-ray detection systems, such as X-ray film, computed radiography (CR) system using a phosphor plate, and digital radiography systems based on the flat panel detector (FPD), just use information derived from the X-ray spectrum; namely, the value of product of fluence and energy as shown in upper right graph of **Fig. 1**. In contrast, a photon counting technique can measure fluence based on the different energy bins as shown in lower right graph of **Fig. 1**, and it has possibilities to derive precise information by analysis of the X-ray spectra. A photon counting technique can derive the energies of the X-rays, meaning that the technique can provide information about material identification. We believe that this technique may be a breakthrough to improve X-ray radiography for medical diagnosis.

Currently in the world photon counting detectors and their techniques have been progressing [1]. A CdTe detector [2] is widely used to measure the X-ray spectrum as shown in **Fig. 2**, and is considered to be a feasible detector to construct a photon counting system. This detector has a high detection efficiency which is read by high density and high atomic number substances of cadmium (Cd:48) and tellurium (Te:52). However, there is a problem of insufficient energy absorptions caused by characteristic X-ray escape and/or Compton scattering X-rays. **Figure 3** indicates the concept of a response function; the response function is defined by an obtained spectrum when monoenergetic photons are introduced to the detector. The effect of insufficient energy absorption is presented in the spectrum (response function). It's important to evaluate the response function precisely.

The origin of response functions can be understood by considering the interactions between X-rays and the CdTe detector. As shown in **Fig. 4**, there are four outcomes in the spectrum; 1)FE: full energy peak, 2)EP: escape peaks, 3)CE: Compton escape, and 4)EE&PE: escape caused by elastic scattering and penetration. The aim of this study is to evaluate the response function of the CdTe detector from the experiment and

simulation. We especially focused our attention on FE and EP, because they are large contributions in the response function. In order to develop an evaluation system using the standard medical X-ray equipment, we newly propose an experimental procedure to measure response functions experimentally.

Images for this section:

Introduction

Knowledge of the **X-ray spectrum** is important to analyze radiography from a viewpoint of the physics.

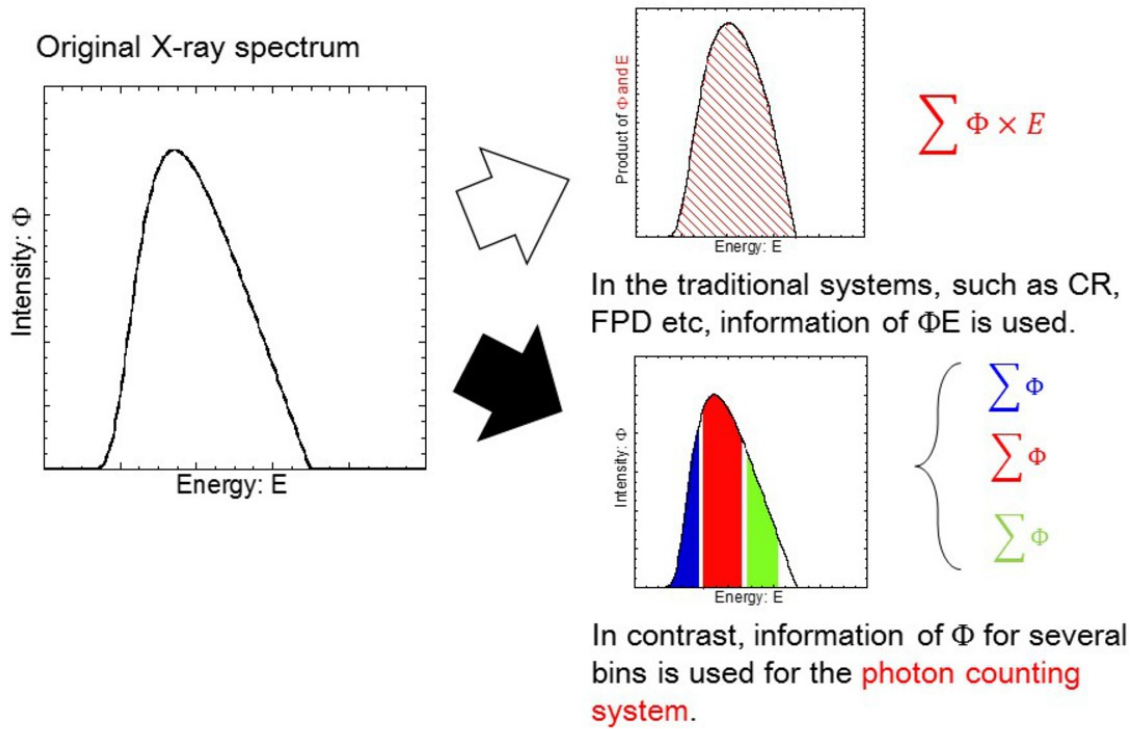
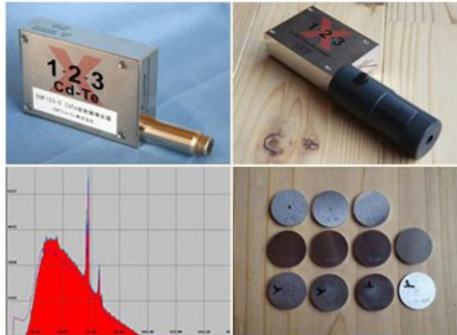


Fig. 1: Relationship between X-ray spectra and detectors used in the creation of medical images.

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How to measure the X-ray spectrum?

CdTe semiconductor detector is widely used.



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<http://www.emf-japan.com/emf/emf123.html>

Good points

High detection efficiency

Bad points

Pileup effect

Dead time

Response function

When experimenters use the detector with proper condition (low counting rate), pileup effect and dead time is sufficiently reduced. In contrast, a **response function** should be considered from the viewpoint of physics.

Fig. 2: CdTe detector to measure X-ray spectrum.

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What is response function?

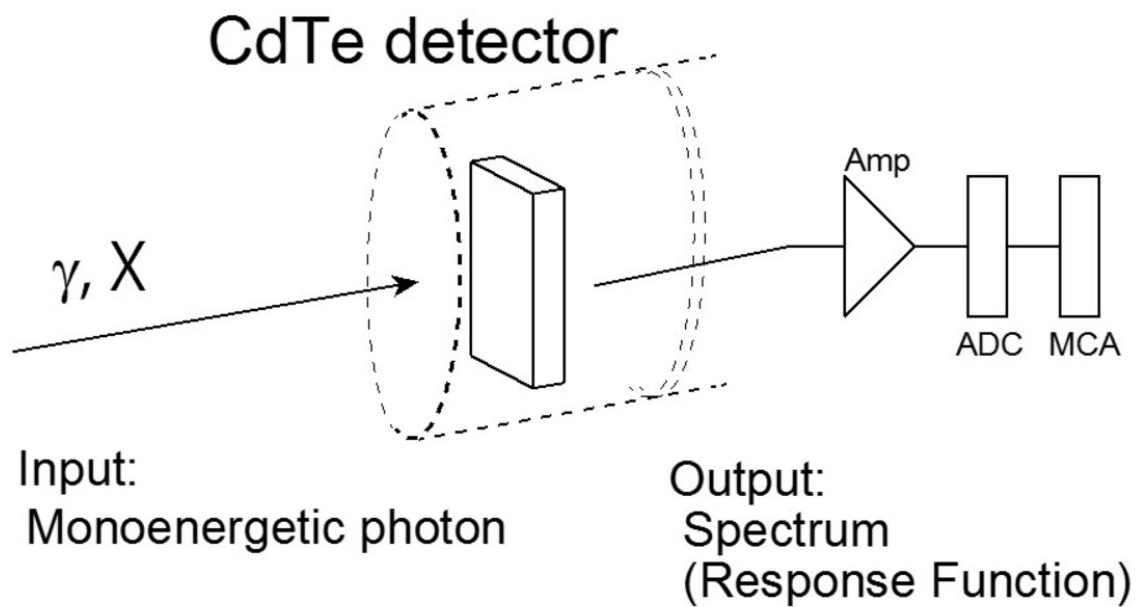


Fig. 3: Concept of the response function.

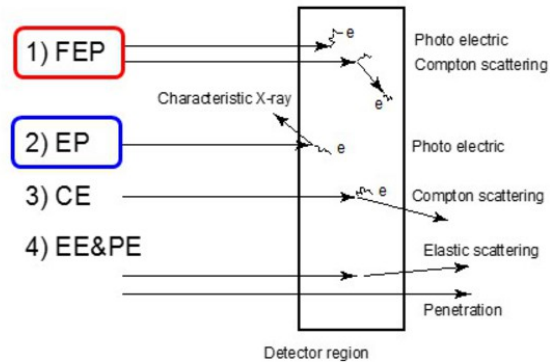
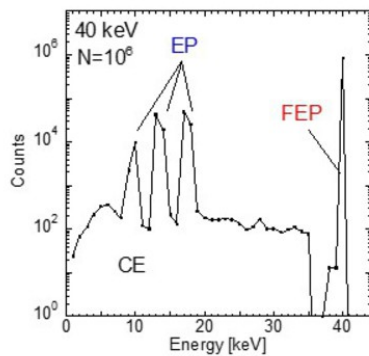
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Importance of evaluation of the response function for CdTe detector

- Information of measured X-ray spectra



Fundamental knowledge of radiology in the diagnostic energy region



Aims To evaluate the response function of CdTe detector by experiment and simulation.

Fig. 4: Relationship between the response function (left) and interactions between X-rays and CdTe detector (right).

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Methods and materials

Figure 5 shows lists of materials used in the present study. In the experiment, we used commercially available X-ray equipment (MRAD-A 50S; Toshiba Medical Systems Co., Nasu, Japan) and a CdTe detector (EMF123; EMF Japan Co., Ltd., Osaka, Japan), combined with an originally constructed experimental apparatus [3]. In the simulation, EGS5 code (electron gamma shower ver.5, KEK, Tsukuba, Japan) [4,5] installed in a personal computer was used. **Figure 6** shows the chart of our study. We evaluated the response function of the CdTe detector from both the experiment and simulation.

In the experiment, we irradiated powdered metallic samples with chemical forms of elemental substances, oxide, and carbon oxide. The irradiated metallic samples emit "characteristic X-rays". The atomic number of metals ranged from 29 to 82 and corresponds to the characteristic X-rays of 8.1 keV to 75.5 keV. The proper tube voltages of the X-ray equipment were set in order to produce the photo electric effect efficiently. A photograph of the experimental setup is shown in **Fig. 7**. The X-ray equipment is seen in the back. The apparatus made from acrylic has collimators, a sample irradiation port and a guide to set the detector; samples were inserted in a small tube, irradiated with collimated X-ray beams. The CdTe detector was set perpendicular to the beam axis. Precise description of the apparatus was previously reported by Fukuda et al. [3]. **Figure 8** summarizes properties of irradiated samples; atomic number, symbol, composition and purity of the sample, energies of K absorption edge, K-alpha rays, K-beta rays and effective energy are listed. The data were calculated by equations in **Fig. 8** based on a well evaluated data base [6].

In the simulation, we calculated the response functions of monoenergetic photons having energies of 20-140 keV. In order to reduce statistical fluctuations, 1 mega incident photons were introduced to the detector. Here we consider two conditions; one is a narrow beam, and the other is a broad beam. In the results section, they will be compared with the experiments.

Images for this section:

Materials used

Experiment

- Diagnostic X-ray equipment (Toshiba, Japan)
- **CdTe Spectrometer** (EMF Japan)
Detector size: 3 mm × 3 mm × 1 mm
- **Experimental apparatus** (Originally developed)
[ref. Fukuda et al., JSRT 69(9), 952-959, 2013]



Simulation

- Monte-Carlo simulation code
EGS5 (electron gamma shower ver.5, KEK, Japan)
[Ref. <http://rcwww.kek.jp/research/egs/kek/>]
- Personal computer
Windows7, CPU:3.2 GHz



Fig. 5: Lists of materials used in the present study.

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Chart of our study

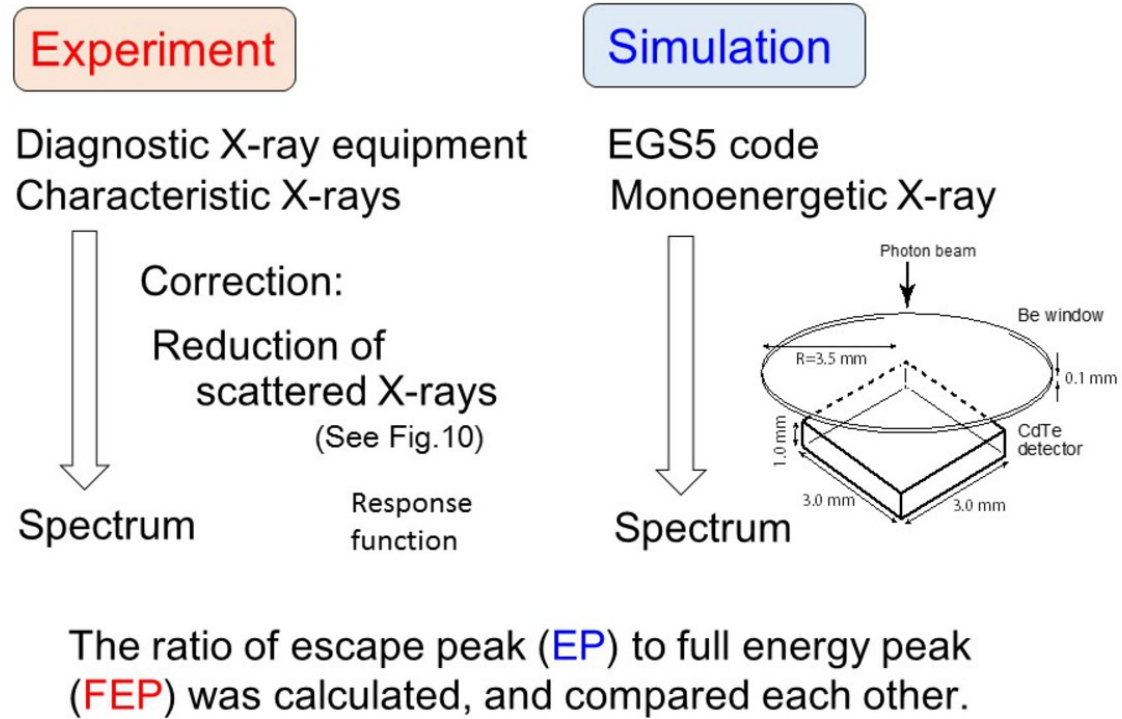
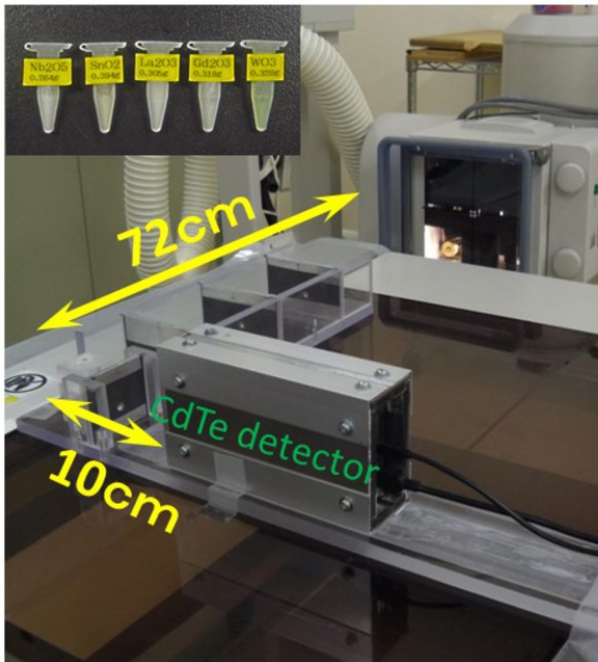


Fig. 6: Chart of our study. We compare two spectra; one is measured with CdTe detector, and another is calculated by Monte-Carlo simulation.

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Experiment

Powder-type samples were irradiated by good collimated X-ray beams. Then, generated characteristic X-rays were introduced to the CdTe detector.



Z	Sample	K_{ab} [keV]	Effective energy [keV]	Tube voltage [kV]
29	Cu	9.0	27.5	50
39	Y ₂ O ₃	17.0	27.5	50
41	Nb ₂ O ₃	19.0	27.5	50
47	Ag	25.5	27.5	50
49	In	27.9	27.5	50
50	SnO ₂	29.2	27.5	50
55	Cs ₂ O ₃	36.0	36.4	100
56	BaCO ₃	37.4	36.4	100
57	La ₂ O ₃	38.9	36.4	100
63	Eu ₂ O ₃	48.5	41.6	130
64	Gd ₂ O ₃	50.2	41.6	130
74	WO ₃	69.5	41.6	130
79	Au	80.7	41.6	130
82	Pb	88.0	41.6	130

X-ray exposure: 1 s×20 times
 Currents were limited so as to obtain the counting rate below 5000 cps.

Fig. 7: Photograph of the experimental setup and list of irradiation conditions.

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Table. Properties of irradiated samples

Z	Symbol	Samples		Energies [keV]			
		Composition	Purity [%]	K _{ab}	E _α	E _β	\bar{E}
29	Cu	Cu	99.99	9.0	8	8.9	8.1
39	Y	Y ₂ O ₃	99.99	17.0	14.9	16.8	15.2
41	Nb	Nb ₂ O ₃	99.9	19.0	16.6	18.7	16.9
47	Ag	Ag	99.99	25.5	22.1	25	22.6
49	In	In	99.99	27.9	24.1	27.4	24.7
50	Sn	SnO ₂	99.9	29.2	25.2	28.6	25.8
55	Cs	Cs ₂ O ₃	99.99	36.0	30.9	35.1	31.6
56	Ba	BaCO ₃	99.999	37.4	32.1	36.4	32.9
57	La	La ₂ O ₃	99.99	38.9	33.3	37.9	34.1
63	Eu	Eu ₂ O ₃	99.99	48.5	41.3	47.2	42.4
64	Gd	Gd ₂ O ₃	99.99	50.2	42.7	48.9	43.9
74	W	WO ₃	99.9	69.5	58.8	67.5	60.6
79	Au	Au	99.9	80.7	68.2	78.3	70.3
82	Pb	Pb	99.99	88.0	74.2	85.3	75.5

$$E_{\alpha} = \frac{\sum_{N=1}^2 (E_{\alpha N} \times I_{\alpha N})}{\sum_{N=1}^2 I_{\alpha N}} \quad E_{\beta} = \frac{\sum_{M=1}^3 (E_{\beta M} \times I_{\beta M})}{\sum_{M=1}^3 I_{\beta M}}$$

$$\bar{E} = \frac{\sum_{N=1}^2 (E_{\alpha N} \times I_{\alpha N}) + \sum_{M=1}^3 (E_{\beta M} \times I_{\beta M})}{\sum_{N=1}^2 I_{\alpha N} + \sum_{M=1}^3 I_{\beta M}}$$

[Ref. Firestone RB et al. Table of Isotopes 8-th edition, Lawrence Berkeley National Laboratory, 1998, appendix F-5.]

Fig. 8: Properties of irradiated samples.

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Results

Figure 9 shows characteristic X-ray spectra measured with the CdTe detector. In the upper row, the spectra of Cu, Y, Nb and Ag have relatively simple constructions in which FEP of K-alpha and K-beta rays are clearly observed. In contrast, the spectra of In, Sn, Cs, Ba and La in the middle row are more complex, namely the EP appears in addition to the FEP. Additionally, the spectra of Eu, Gd W, Au and Pb in the lower row show L series X-rays in the low energy region in addition to the EP and FEP.

In fact, the background component caused by the Compton scattering of the incident X-rays is superimposed to the characteristic X-rays. **Figure 10** represents this phenomena. The red arrow in **Fig. 10** indicates the characteristic X-rays that are generated by the samples. The blue arrow shows Compton scattering X-rays that become an unnecessary background component. In our experiment as shown in **Fig. 7**, we set the detector perpendicular to the beam axis to reduce the background component. We do this because the intensity of Compton scattered X-rays at 90 degree is relatively low according to the Klein-Nishina formula [7,8]. Here, we propose a new methodology to remove the Compton-scattering X-rays in the measured spectrum. Using the measured spectra of La shown in **Fig. 11**, we exemplify the methodology of background reduction. During the experiment, we also measured the spectrum of water. Because water is composed of hydrogen and oxygen (low Z atoms), the characteristic X-rays from them are negligibly small. In the theoretical consideration of the Compton scattering, the distribution of the scattered X-rays were not depend on the atomic number. Therefore, we assumed that the spectrum only consisted of the background component. Then, we subtracted the background spectrum (water) from the measured spectrum of La. At that time, the factor of "k" was multiplied by the background spectrum so as to agree with the background component in the La spectrum. The right figure in **Fig. 11** represents the background subtracted La spectrum, which is an experimentally derived response function. Although the FEP of this response function consists of K-alpha and K-beta rays, we assume these X-rays as a composite peak having an effective energy as represented in **Fig. 8**.

Typical simulated spectra were presented in **Fig. 12**. The upper images (computer graphics) show simulated tracks; the yellow lines indicate X-rays, and a green circle and purple cube show the Be window and CdTe detector, respectively. The image is created by "CG-view" which is software to display the simulated results of EGS5 [4,5]. The lower figures show the response functions simulated by EGS5, in which the FEP, EP and CE components are clearly observed. In the simulation, the number of incident photons was known, therefore the EE&PE components could be calculated. **Figure 13**

shows energetic dependence of the components. It is difficult to evaluate the EE&PE values in the experiment. Therefore, we focused attention on the two values, FEP and EP, and then the ratio of the two values from experiment were calculated and compared with the simulation.

Using **Fig. 14**, we discuss the identification of the EP. When a photoelectric effect occurs in Cd atom, characteristic X-rays of 23 keV (K-alpha) or 26 keV (K-beta) are emitted and some of them escape from the detector. In this case, escape peaks appear as indicated by "A" and "B" in the lower right figure of **Fig. 14**. In the similar way, when photoelectric effect occurs in the Te atom, characteristic X-rays of 27 keV (K-alpha) or 31 keV (K-beta) are emitted and formed escape peaks of "B" and "C". Energies of K-alpha of Te and K-beta of Cd are similar, so they become the doublet peaks "B". Consequently, there are three EP of "A", "B" and "C" in the response function as represented by lower right figure in **Fig. 14**. In contrast in the measured response function as shown in left figure of **Fig. 14**, there are two incident X-rays, K-alpha and K-beta of the metallic atom. The blue and red solid lines in the graph indicate a relation between the FEP and EP. Although the EP in the measured spectrum is complexed, we can identify all peaks based on the analysis described above.

In order to evaluate the simulated response function, we calculate the ratio of EP to the FEP, and compared those with the experimental values. A schematic drawing is presented in **Fig. 15**. **Figure 16** shows the comparison between the measured EP/FEP and simulated data. The experimental values of EP/FEP are in good agreement with the simulated values. This fact can be interpreted as the EGS5 code being able to produce the response function of the CdTe detector. The X-axis error of the experimental data is defined by the range between the minimum and maximum energies of the characteristic X-rays. In the next paragraph, we described the Y-axis error.

The error of the EP/FEP are evaluated by considering the systematic and statistical uncertainties as shown in **Fig. 17**. The systematic uncertainty originated from the subtraction of the background. So we estimate the accuracy to determine the factor of "k" and the effect on EP/FEP is evaluated. For the EP/FEP, effect of the statistical uncertainty caused by the Poisson distribution is also estimated. Then, total error of the EP/FEP is calculated using the error propagation formula [8]. The estimated total errors were 2-6% for low Z atoms and greater than 10% for high Z atoms. Our method can achieve sufficient accuracy to evaluate the response function of the CdTe detector.

Finally, we present the application of the response functions calculated by EGS5. One of the important applications of the response functions is to unfold the measured spectra. The spectra measured with the CdTe detector has distortions caused by EP as well as other things. Therefore the spectra should be unfolded with the response function. Based on the simulated response functions, we made a program for unfolding in which a stripping method has been applied [9]. **Figure 18** shows a comparison between the unfolded spectra and Birch's formula, which is widely used as a standard X-ray spectrum [10]. The unfolded spectra for 60 kV and 80 kV X-ray spectra are in good agreement with Birch's formula. This fact is consistent with the present study; the response function calculated by the EGS5 is available to analyze the spectra measured with the CdTe detector.

Images for this section:

Measured characteristic X-ray spectra

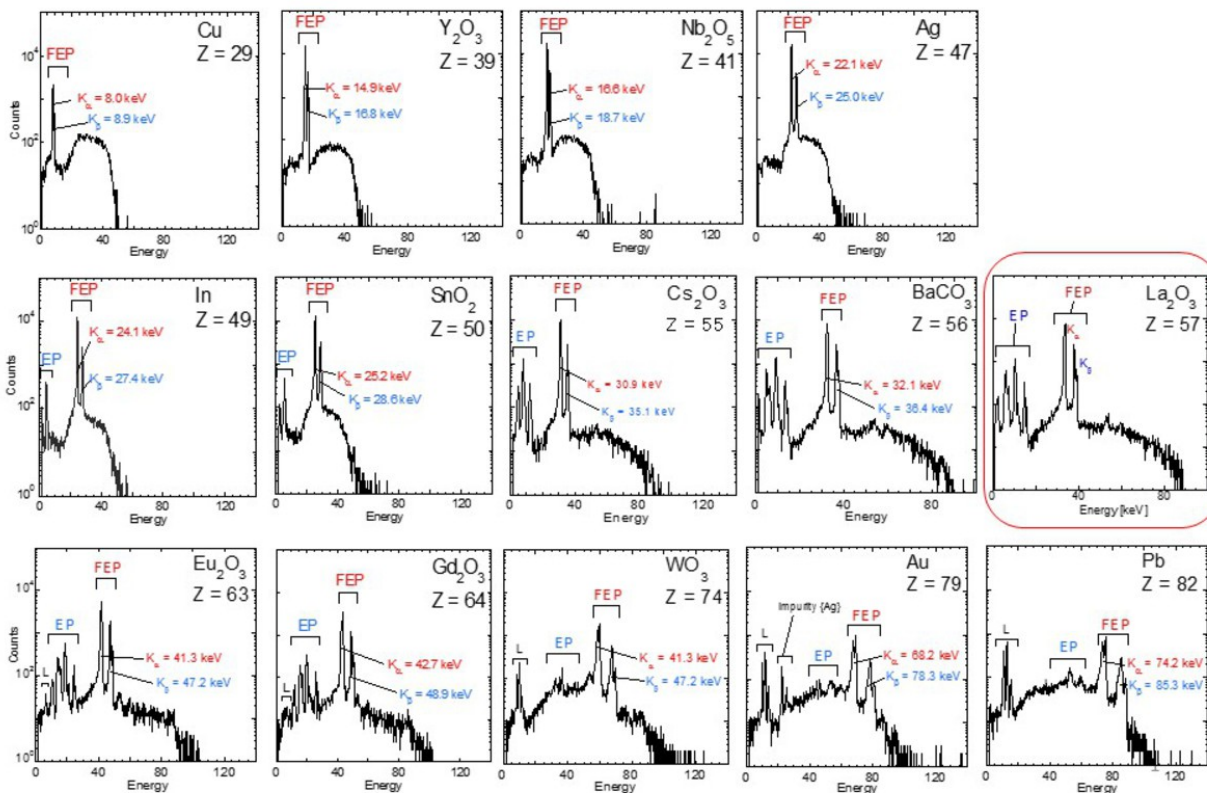


Fig. 9: Characteristic X-ray spectra measured with the CdTe detector. FEP is clearly observed for all samples. For samples having high atomic number, there are EP and L-rays in addition to the FEP.

Contaminations of Compton-scattered X-rays in the measured X-ray spectrum

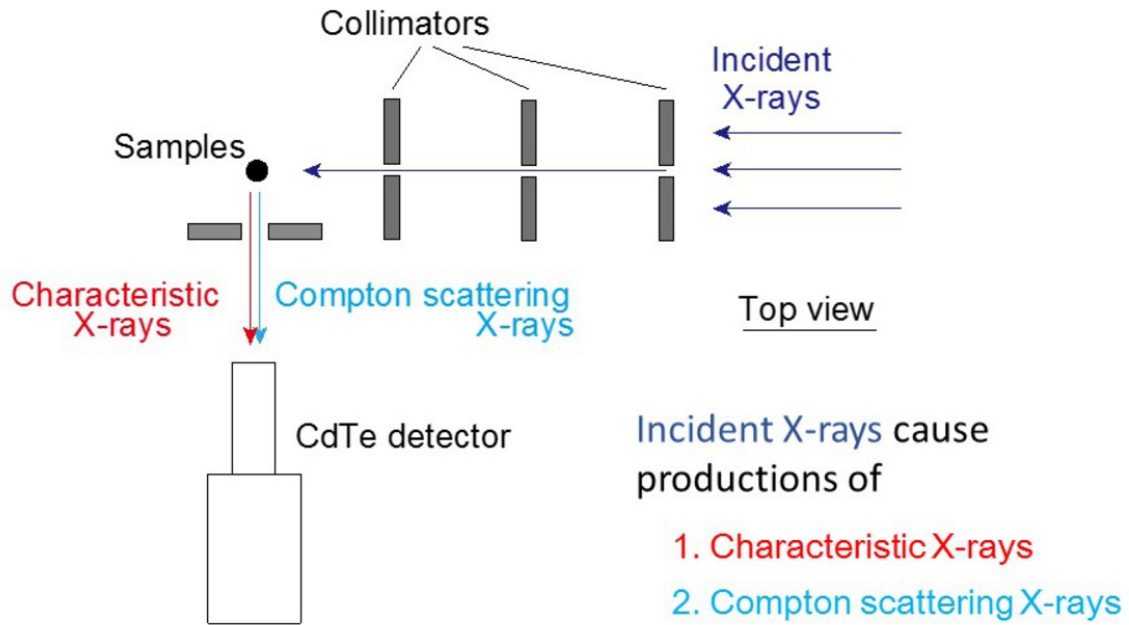


Fig. 10: Schematic drawing to explain the generation of the characteristic X-rays and Compton scattering X-rays.

Reduction methodology of BG contamination in measured spectra

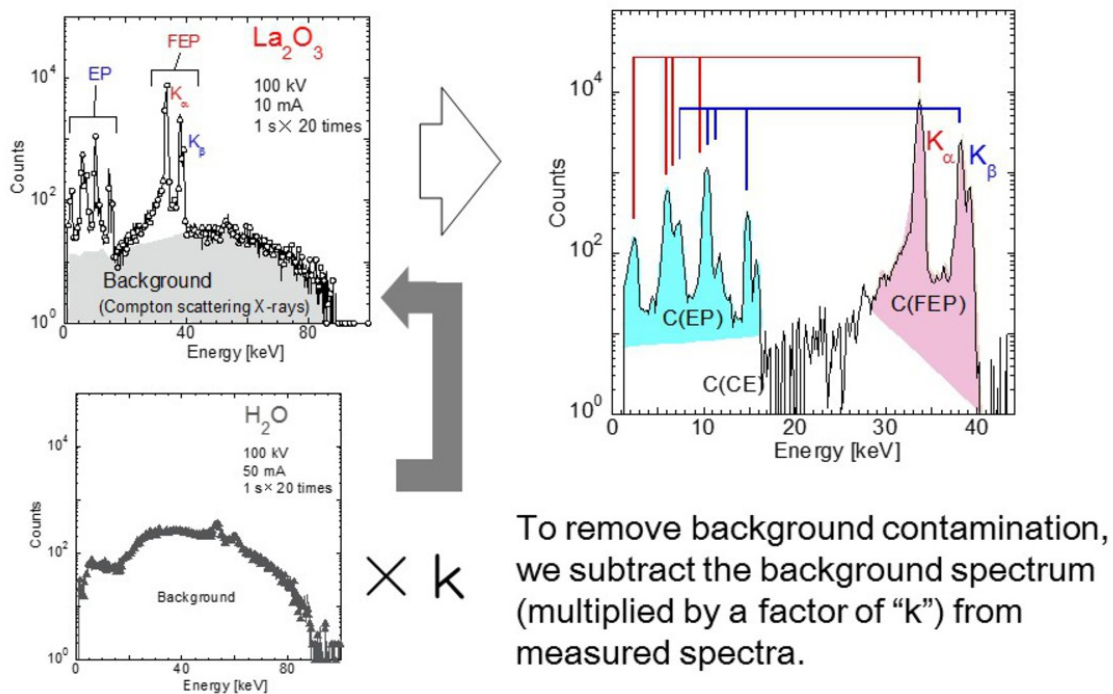
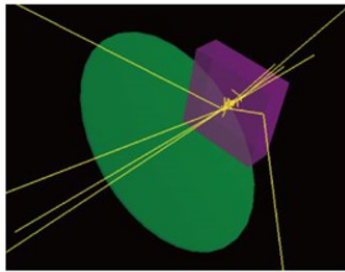


Fig. 11: Example of the background subtraction in La. We assumed that the water sample spectrum is only composed of the Compton-scattering X-rays. Then, the background spectrum was subtracted from the measured spectrum of La.

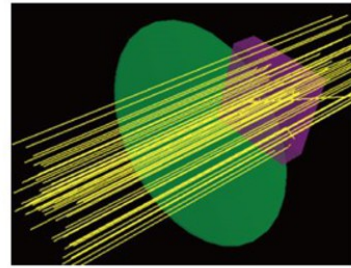
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Simulation

Monoenergetic photon
20-140 [keV]



Narrow beam



Broad beam ($3 \times 3 \text{ mm}^2$)

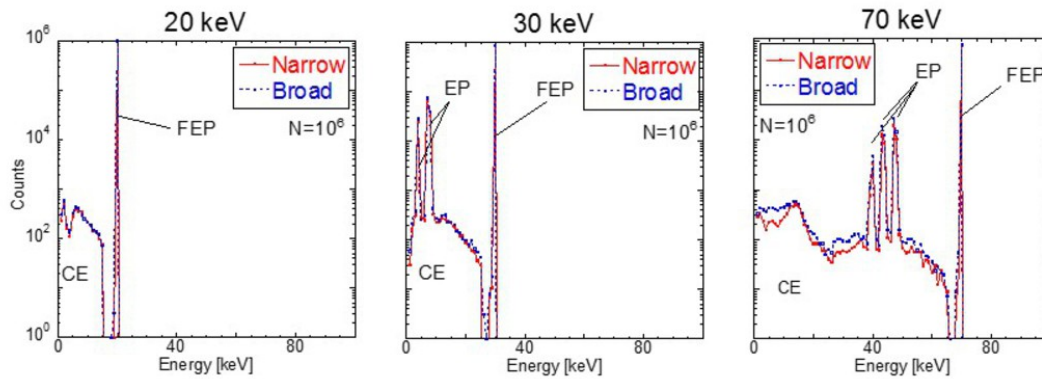


Fig. 12: Response functions simulated by EGS5.

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Ratio of each component of calculated response function

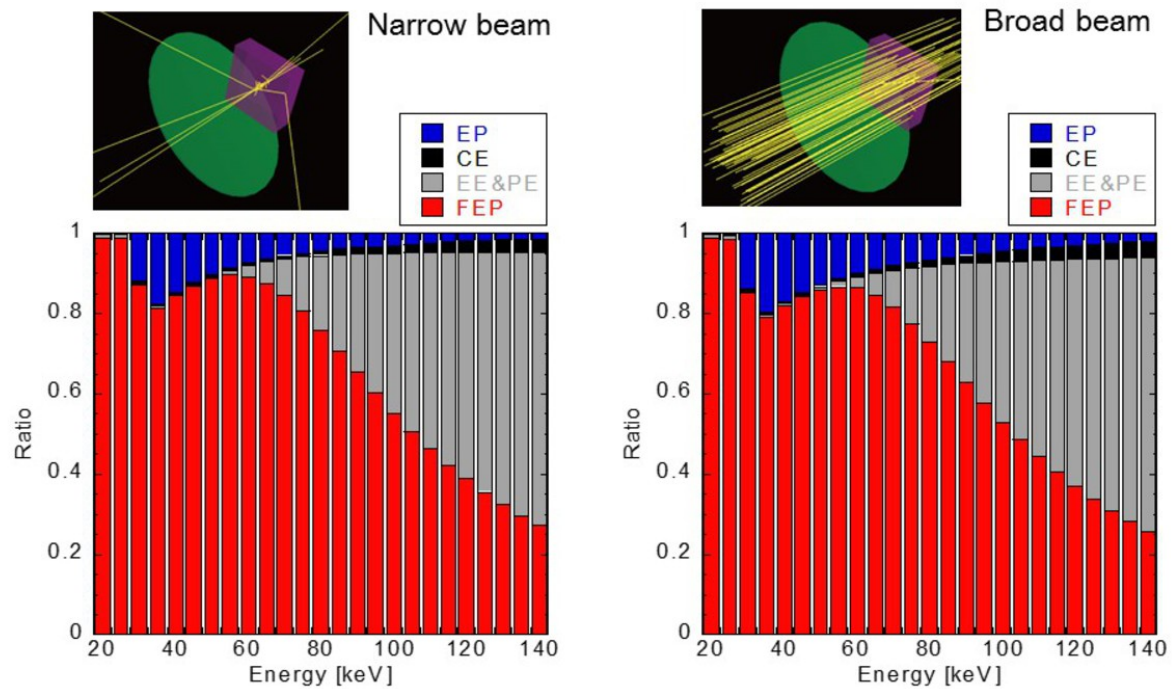


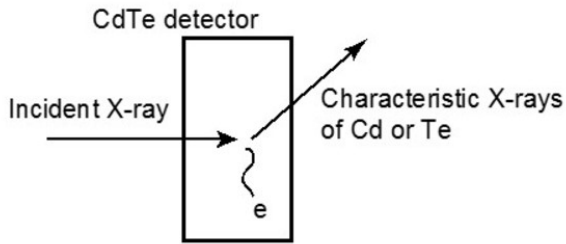
Fig. 13: Energy dependence of the ratio of FEP, EP, CE and EE&PE of the simulated spectra.

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Identification of the escape peaks (EP)

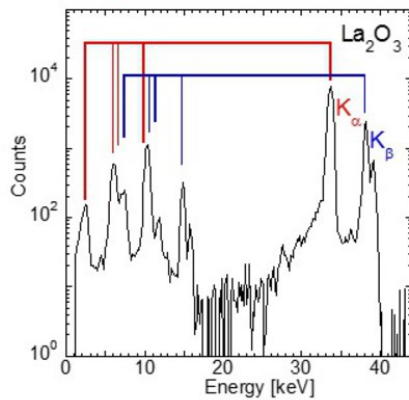
Caused by the photoelectric effect

Characteristic X-ray of CdTe detector



		Cd	Te
E'	K _α	23 keV (A)	27 keV (B)
	K _β	26 keV (B)	31 keV (C)

Experiment



Simulation (EGS5)

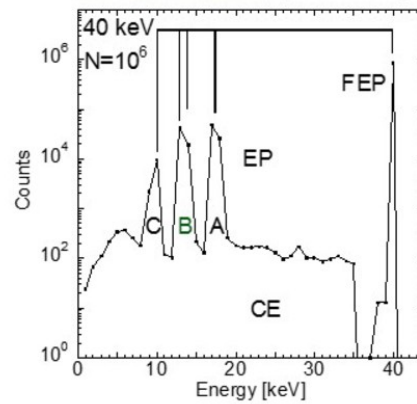
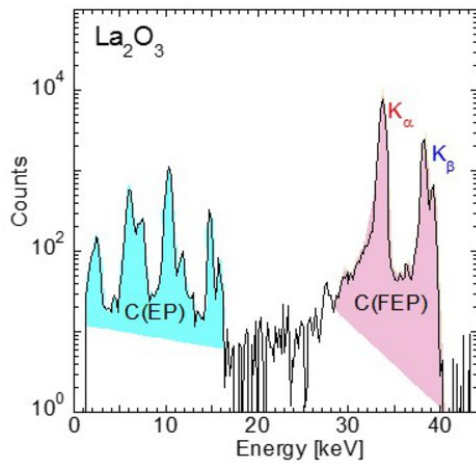


Fig. 14: Identification methodology of the escape peaks.

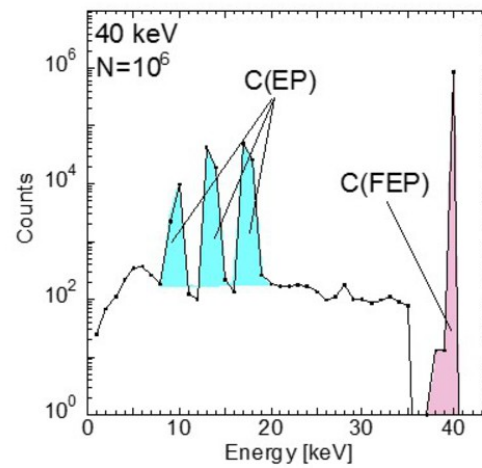
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Analysis

Experiment



Simulation: EGS5



Focusing attention to the ratio of **escape peaks (EP)** to **full energy peak (FEP)**, experimental values were compared with the simulation.

Fig. 15: Schematic drawing of the analysis. The ratio of EP to FEP is calculated.

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Comparison of EP/FEP

The experimental values of EP/FEP are in good agreement with the simulated ones. This fact means that **EGS5 code can produce the response function** of the CdTe detector.

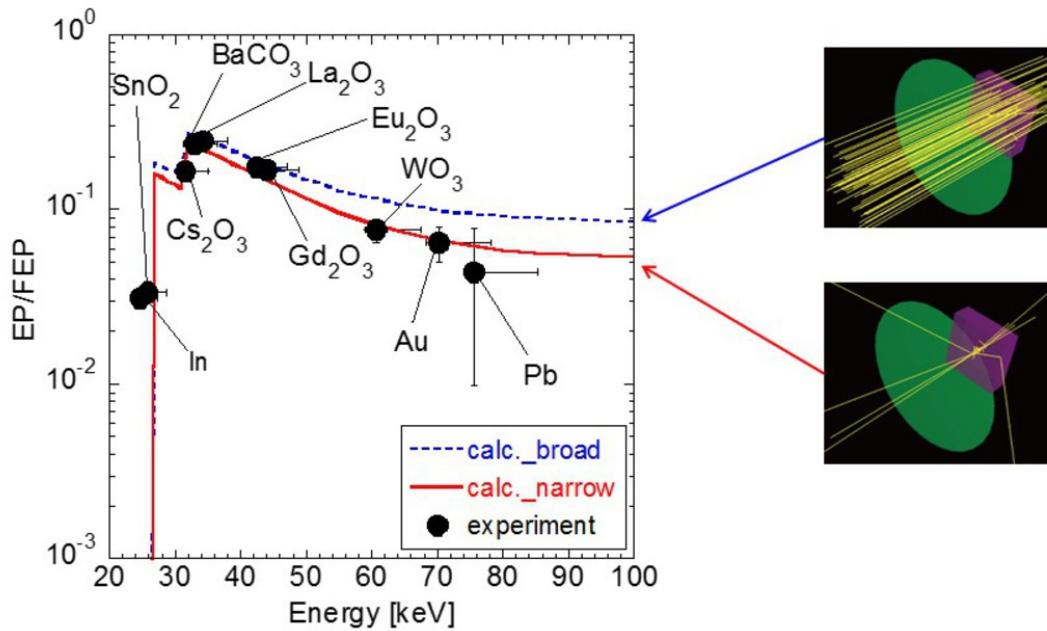


Fig. 16: Comparison of EP/FEP; experimental and simulation.

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Evaluation of the errors in EP/FEP

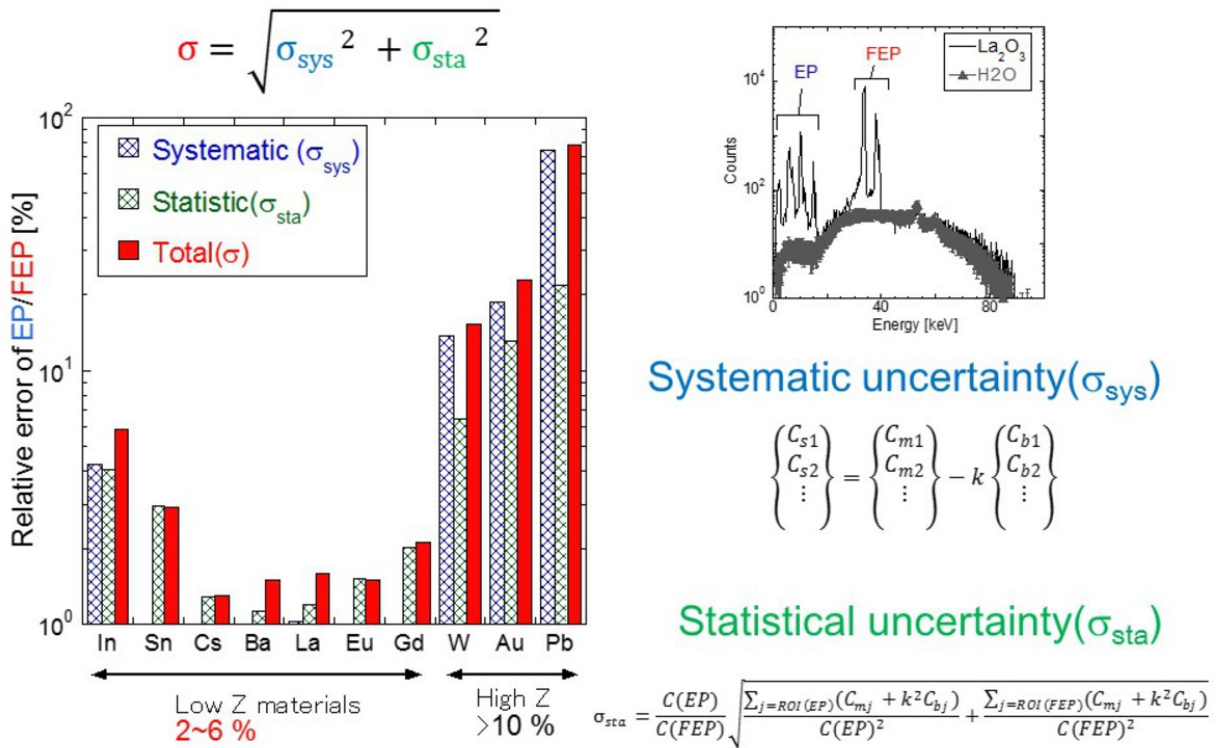


Fig. 17: Error estimation of the measured EP/FEP. The systematic and statistical uncertainties are taken into account.

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Comparison between unfolded spectra and Birch's formula

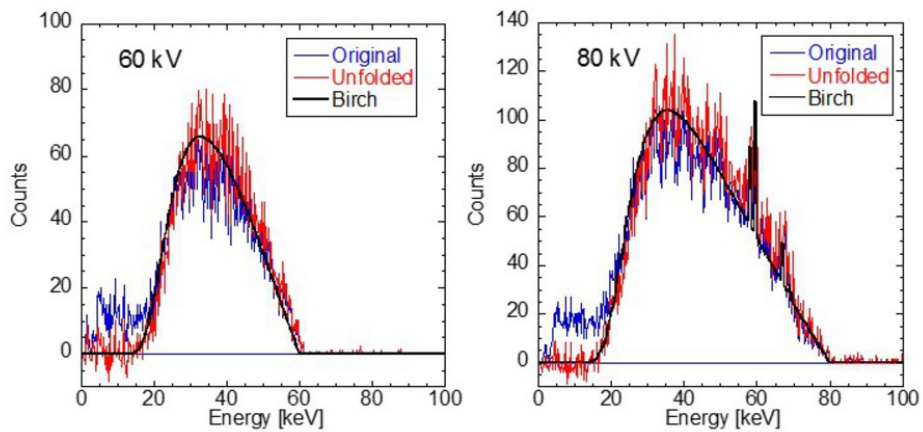


Fig. 18: Comparison between unfolded spectra and Birch's formula.

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Conclusion

In this study, we newly proposed the experimental method to evaluate the response functions of the CdTe detector. In our method, metallic samples were irradiated with diagnostic X-rays. The CdTe detector was exposed to characteristic X-rays caused by the photoelectric effect. In the EPOS, experimentally measured spectra of samples having atomic numbers of 29-82 were presented. Additionally, using the Monte-Carlo simulation code (EGS5), response functions were calculated. In order to evaluate the simulated response functions, all of observed peaks were identified and the ratio of escape peaks to the full energy peak (EP/FEP) was derived. The ratio derived from simulation was in good agreement with that of the experiment. Therefore, we conclude that the response functions calculated by EGS5 are valuable to evaluate interactions between X-rays and the CdTe detector. Recently, developing a photon counting technique is in progress, and the CdTe detector is considered to be used for the photon counting technique. Our present data and the proposed methodology are valuable to the advancement of this research (see **Fig. 19**).

Images for this section:

Conclusion

- We proposed **new method** to evaluate the response function of the CdTe detector.
- In our method, **characteristic X-rays** of metallic atoms are generated by irradiation of the diagnostic X-rays.
- Moreover, using the simulation code (**EGS5**), the response functions are also calculated.
- In order to evaluate the response functions, **the ratio of escape peaks to the full energy peak (EP/FEP)** was calculated.
- The simulated results were **in good agreement** with the experiments. This results indicate that the EGS5 is valuable tool to estimate the response of the CdTe detector.

Fig. 19: Summary of the present study.

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